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The ultrasonic calibration device illustrated is an instrument for producing known changes in both acoustic absorption and phase velocity. The calibration signal arises from an actual change of acoustic parameters, not from an electrical simulation. Changes in ultrasonic time-domain decay rates or frequency-domain line widths are produced. Thus, the instrument is able to simulate not only changes in ultrasonic absorption and phase velocity but also in the sensitivity enhancement achieved by the use of ultrasonic resonators. The latter simulation cannot be achieved using electrical calibration techniques.

The components of this ultrasonic calibration device are shown in the illustration. The composite resonator consists of a CdS crystal bonded to an appropriate transducer. The flat and parallel single crystal of CdS is prepared from a high-purity photoconducting material. Light from both the bias and the signal lamps, which are powered by constant-current sources, is focused on the CdS crystal. A light chopper and a platform carrying neutral-density filters are in the optical path of the signal lamp. The entire assembly is housed in a lighttight case, external to which are controls that insert or retract various combinations of neutral-density filters.

The physical basis for the calibration scheme is as follows. Because CdS is a good photoconductor, light incident on the crystal can change its electrical conductivity by many orders of magnitude. Since the charge carriers are coupled to the elastic properties of CdS by the piezoelectric mechanism, changes in electrical conductivity result in changes in ultrasonic phase velocity and absorption.

(continued overleaf)

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The intensity of the bias lamp is adjusted to produce a background ultrasonic absorption, α_0 , equal to that of the specimen being simulated. By adjusting the bias light level, α_0 can be varied by nearly two orders of magnitude (from about 0.03 cm⁻¹ to 1.6 cm⁻¹; or 0.1 dB/ μ s to 6 dB/ μ s), which will permit the α_0 of many specimens of ultrasonic interest to be simulated.

After the appropriate α_0 is selected, initial calibration of the instrument is achieved by comparison with external standards, a precision attenuator for the case of absorption and a frequency counter for the case of dispersion. Once this simple initialization procedure has been carried out, the instrument is capable of producing accurately known changes in ultrasonic attenuation and phase velocity over a wide dynamic range.

For dc-coupled systems, the light chopper is switched off. Changes in ultrasonic parameters are produced by the appropriate insertion, or removal, of neutral-density filters in the signal-lamp optical path. For ac-coupled systems, the light chopper produces a modulation of ultrasonic absorption and/or dispersion at the chopping frequency. Calibrated changes in the amplitude of this modulation are achieved with the aid of the neutraldensity filters.

Note:

Requests for further information may be directed to: Technology Utilization Officer Langley Research Center Mail Stop 139-A Hampton, Virginia 23665 Reference: B73-10420

Patent status:

Inquiries concerning rights for the commercial use of this invention should be addressed to:

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> Source: Joseph S. Heyman Langley Research Center and J. G. Miller of Washington University under contract to Langley Research Center (LAR-11435)